Search Notes		

	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/706,953	KIM ET AL.
ſ	Examiner	Art Unit
	Shih-wen Hsieh	2861

	SEAR	CHED	
Class	Subclass	Date	Examiner
347	updated	1/4/2006	SWH
257	updated	1/4/2006	sWH
438	updated	1/4/2006	SWH
174	updated	1/4/2006	SWH

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
				
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SEARCH NOT (INCLUDING SEARCH	ES STRATEGY)
	DATE	EXMR
USPGPUB text search (see attached)	1/4/2006	Anvit SWH
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